



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. .... 10/050,347  
Filing Date ..... January 15, 2002  
Inventor ..... Gurtej S. Sandhu et al.  
Assignee ..... Micron Technology, Inc.  
Group Art Unit ..... 2813  
Examiner ..... Laura M. Schillinger  
Attorney's Docket No. .... MI22-1897  
Title: Methods of Forming Transistors

**SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT**

References -- See Attached Form PTO-1449

The attached Form PTO-1449 is submitted in compliance with 37 CFR §1.56. Pursuant to FEDERAL REGISTER, Vol. 69, No. 182, pg. 56542 (September 21, 2004), no copies of any cited U.S. patents or U.S. published applications are included herewith. Copies of all other cited art are attached. No admission is made regarding whether the listed references are prior art.

Respectfully submitted,

Dated: December 5, 2006

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Jennifer J. Taylor, Ph.D.  
Reg. No. 48,711

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| Form PTO-1449  |    | U.S. DEPARTMENT OF COMMERCE<br>PATENT AND TRADEMARK OFFICE |          |                 | ATTY. DOCKET NO.<br>MI22-1897   |           | SERIAL NO.<br>10/050,347   |    |
| <div style="position: relative; height: 100px;"> <div style="position: absolute; top: 0; left: 0; width: 100%; height: 100%; border: 1px solid black; border-radius: 50%; text-align: center; font-size: 10px; line-height: 1;"> O I P E<br/>DEC 05 2006<br/>PATENT AND TRADEMARK OFFICE </div> </div> |    |  |          |                 | LIST OF ART CITED BY APPLICANT<br>(Use several sheets if necessary)         |           |                            |    |
|  |    |  |          |                 | APPLICANT<br>Gurtej S. Sandhu et al.<br><br>FILING DATE<br>January 15, 2002 |           |                            |    |
| U.S. PATENT DOCUMENTS  |    |  |          |                 |   |           |                            |    |
| *Examiner Initial  |    | Document Number  | Date     | Name            | Class   | Sub-class | Filing Date If Appropriate |    |
|  | AA | 6,060,406  | 05/09/00 | Alers, et al.   |   |           |                            |    |
|  | AB |  |          |                 |   |           |                            |    |
|  | AC |  |          |                 |   |           |                            |    |
|  | AD |  |          |                 |   |           |                            |    |
|  | AE |  |          |                 |   |           |                            |    |
|  | AF |  |          |                 |   |           |                            |    |
| FOREIGN PATENT DOCUMENTS   |    |  |          |                 |   |           |                            |    |
|  |    | Document Number  | Date     | Country         | Class   | Sub-class | Translation                |    |
|  |    |  |          |                 |   |           | Yes                        | No |
|  | AN |  |          |                 |   |           |                            |    |
|  | AO |  |          |                 |   |           |                            |    |
|  | AP |  |          |                 |   |           |                            |    |
| OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)  |    |  |          |                 |   |           |                            |    |
|  | AS |  |          |                 |   |           |                            |    |
|  |    |  |          |                 |   |           |                            |    |
|  | AT |  |          |                 |   |           |                            |    |
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| EXAMINER   |    |  |          | DATE CONSIDERED |   |           |                            |    |
| <p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>   |    |  |          |                 |   |           |                            |    |

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